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QN	1	10-320323	12-4-98	Japan	abstract	only	1			
ar	2	2001-111628	4-20-01	Japan	abstract	only	1			
ar	3	08-237285	9-13-96	Japan	abstract	only	1			
ar	4	11-098144	4-9-99	Japan	abstract	only	1			
ar	5	11-122284	4-30-99	Japan	abstract	only	1			
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